



YOUSHANG SEMICONDUCTOR

**设计研发新型功率器件**

**各类小信号开关**

**中低压及高压大电流等场效应管**

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## Product Summary

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C
-25V	10Ω @ V <sub>GS</sub> = -4.5V	-150mA
	13Ω @ V <sub>GS</sub> = -2.7V	-140mA

## Features and Benefits

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected

## Description

This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(ON)</sub>) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## Applications

- General Purpose Interfacing Switch
- Power Management Functions
- Analog Switch

## Mechanical Data

- Case: SOT363
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish Annealed over Alloy 42 Leadframe (Lead Free Plating). Solderable per MIL-STD-202, Method 208③
- Terminal Connections: See Diagram
- Weight: 0.006 grams (Approximate)

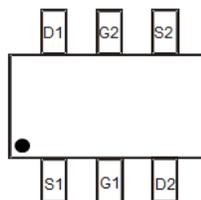


ESD Protected

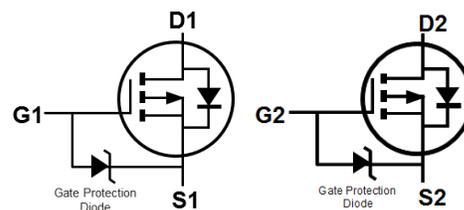
SOT363



Top View



Top View



Equivalent Circuit

**Maximum Ratings – Total Device** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P <sub>D</sub>	310	mW
Thermal Resistance, Junction to Ambient (Note 5)	R <sub>θJA</sub>	407	°C/W
Power Dissipation (Note 6)	P <sub>D</sub>	380	mW
Thermal Resistance, Junction to Ambient (Note 6)	R <sub>θJA</sub>	326	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

**Maximum Ratings P-CHANNEL** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-25	V
Gate-Source Voltage	V <sub>GSS</sub>	±8	V
Continuous Drain Current (Note 6) V <sub>GS</sub> = -4.5V	I <sub>D</sub>	T <sub>A</sub> = +25°C	-150
		T <sub>A</sub> = +70°C	-120
Continuous Drain Current (Note 6) V <sub>GS</sub> = -2.7V	I <sub>D</sub>	T <sub>A</sub> = +25°C	-140
		T <sub>A</sub> = +70°C	-110

**Electrical Characteristics P-CHANNEL** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 7)</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-25	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	—	—	-1.0	μA	V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V
Gate-Body Leakage	I <sub>GSS</sub>	—	—	-100	nA	V <sub>GS</sub> = -8V, V <sub>DS</sub> = 0V
<b>ON CHARACTERISTICS (Note 7)</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-0.65	—	-1.5	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	—	2	10	Ω	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -0.14A
		—	2.7	13	Ω	V <sub>GS</sub> = -2.7V, I <sub>D</sub> = -0.05A
Diode Forward Voltage	V <sub>SD</sub>	—	-0.8	-1.2	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -0.2A
<b>DYNAMIC CHARACTERISTICS (Note 8)</b>						
Input Capacitance	C <sub>iss</sub>	—	30.7	—	pF	V <sub>DS</sub> = -10V, V <sub>GS</sub> = 0V f = 1.0MHz
Output Capacitance	C <sub>oss</sub>	—	5.9	—		
Reverse Transfer Capacitance	C <sub>rss</sub>	—	1.5	—		
Total Gate Charge	Q <sub>g</sub>	—	0.34	—	nC	V <sub>DS</sub> = -5V, I <sub>D</sub> = -0.2A, V <sub>GS</sub> = -4.5V
Gate-Source Charge	Q <sub>gs</sub>	—	0.06	—		
Gate-Drain Charge	Q <sub>gd</sub>	—	0.08	—		
Turn-On Delay Time	t <sub>D(ON)</sub>	—	3.3	—	ns	V <sub>GS</sub> = -4.5V, V <sub>DD</sub> = -6V I <sub>D</sub> = -0.2A, R <sub>G</sub> = 50Ω
Turn-On Rise Time	t <sub>R</sub>	—	2.0	—		
Turn-Off Delay Time	t <sub>D(OFF)</sub>	—	16.3	—		
Turn-Off Fall Time	t <sub>F</sub>	—	7.9	—		

- Notes:
- Device mounted on FR-4 PCB, with minimum recommended pad layout.
  - Device mounted on 1" × 1" FR-4 PCB with high coverage 2oz. Copper, single sided.
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to product testing.

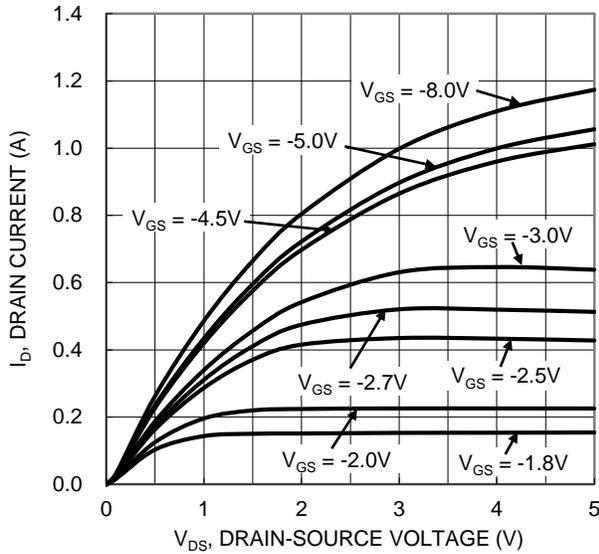


Figure 1. Typical Output Characteristic

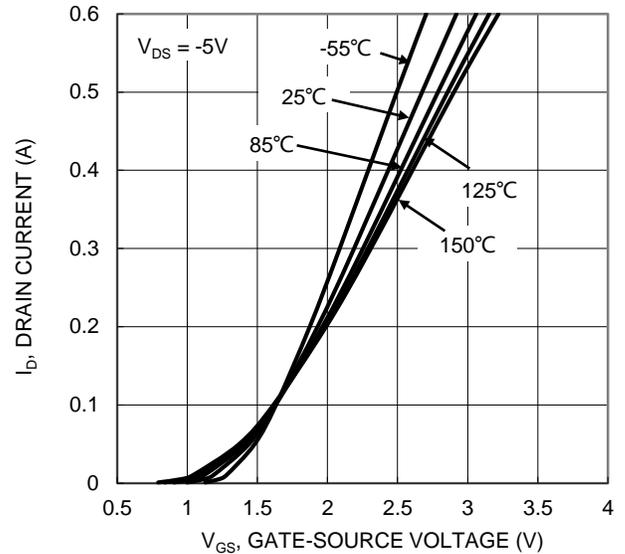


Figure 2. Typical Transfer Characteristic

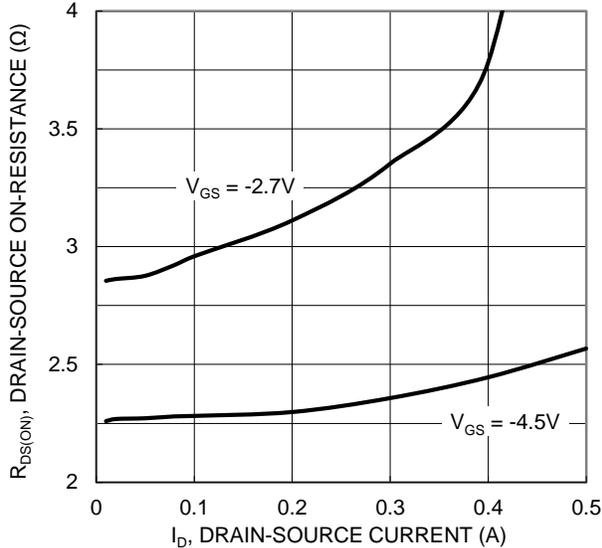


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

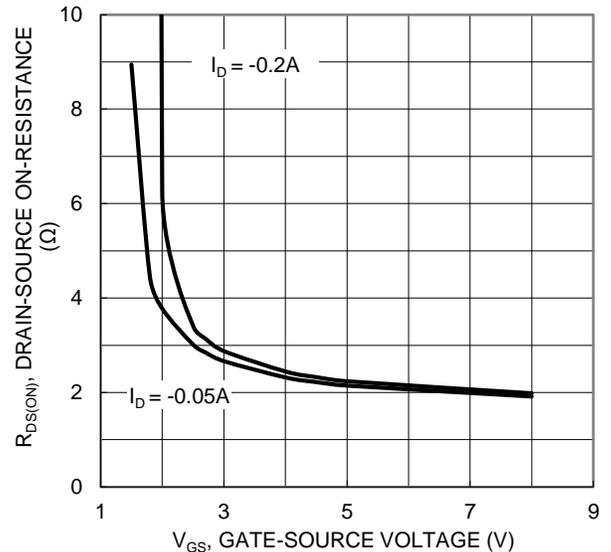


Figure 4. Typical Transfer Characteristic

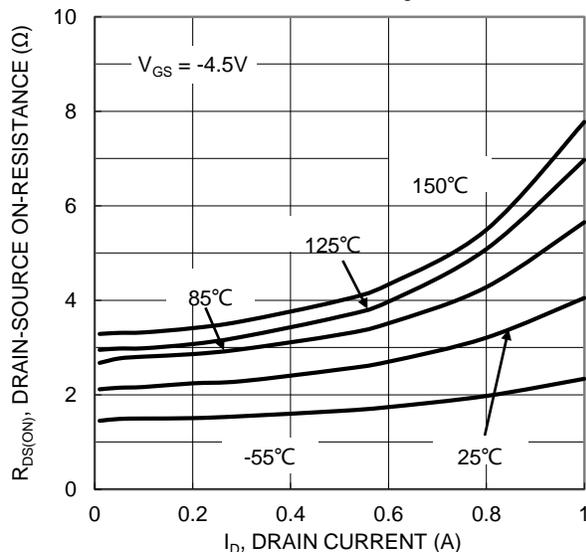


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

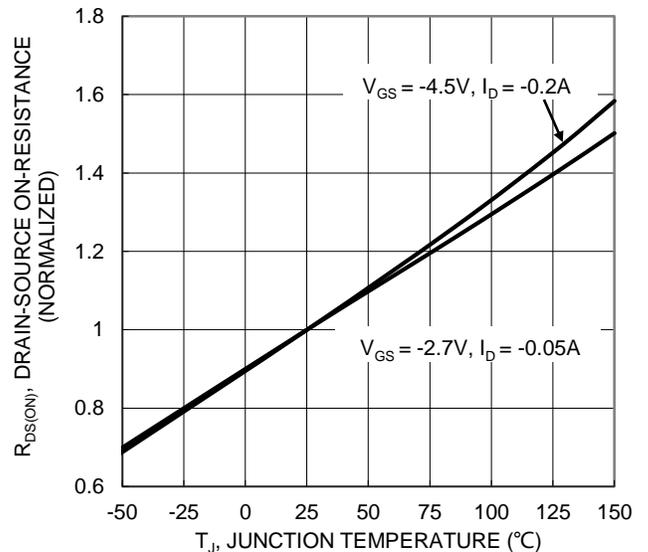


Figure 6. On-Resistance Variation with Temperature

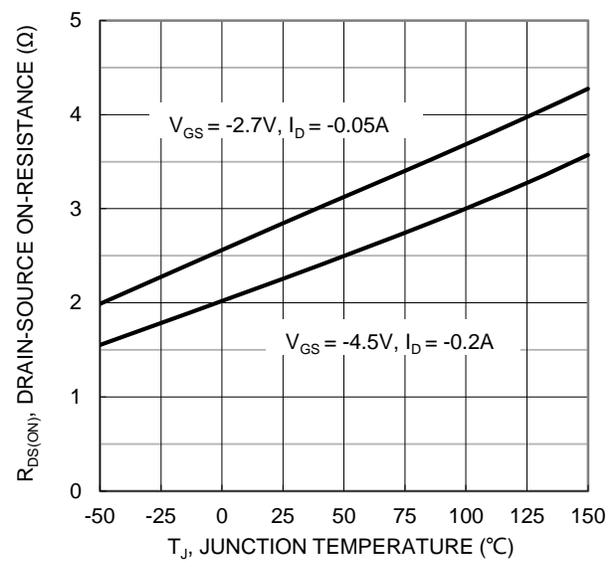


Figure 7. On-Resistance Variation with Temperature

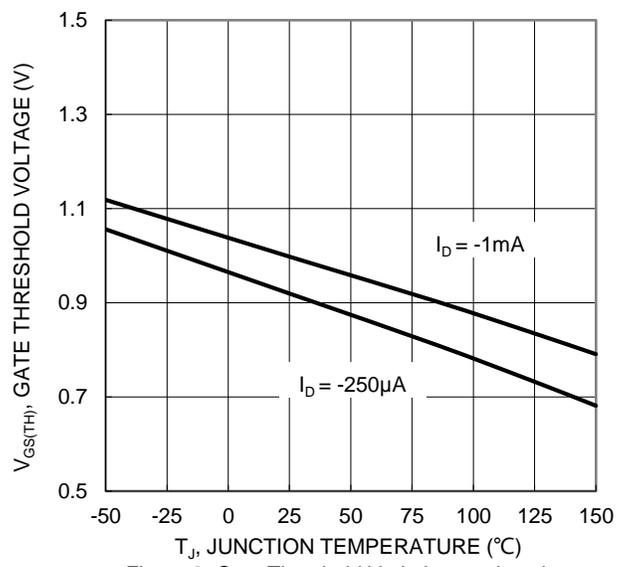


Figure 8. Gate Threshold Variation vs. Junction Temperature

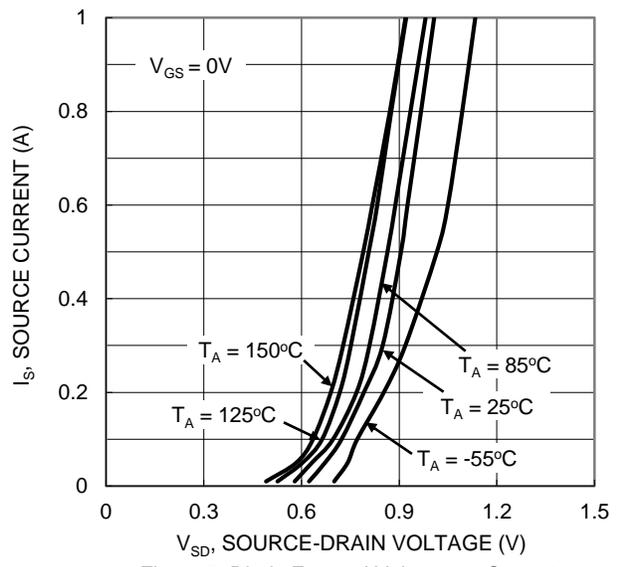


Figure 9. Diode Forward Voltage vs. Current

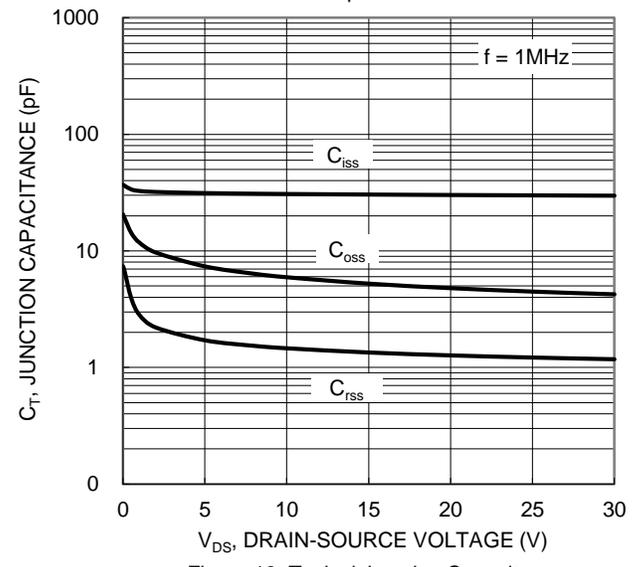


Figure 10. Typical Junction Capacitance

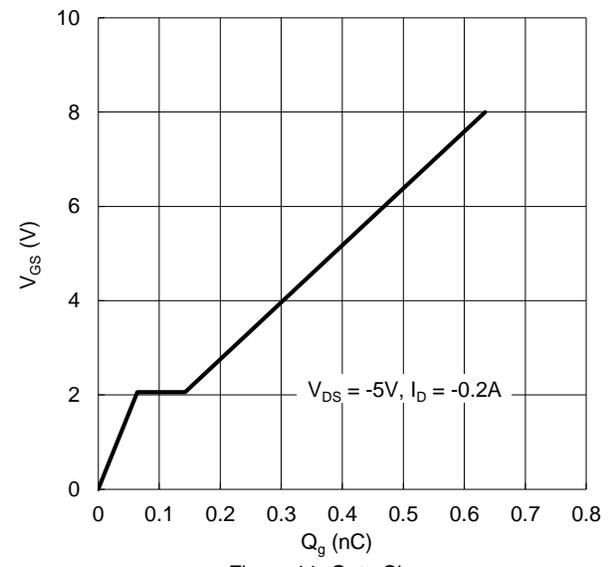


Figure 11. Gate Charge

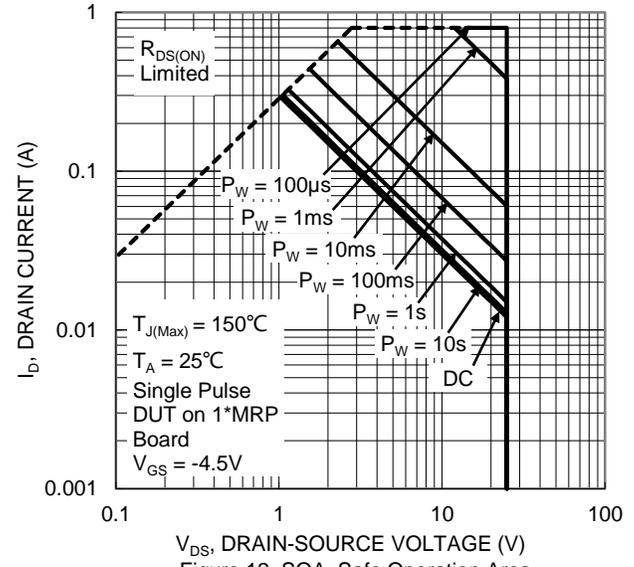


Figure 12. SOA, Safe Operation Area

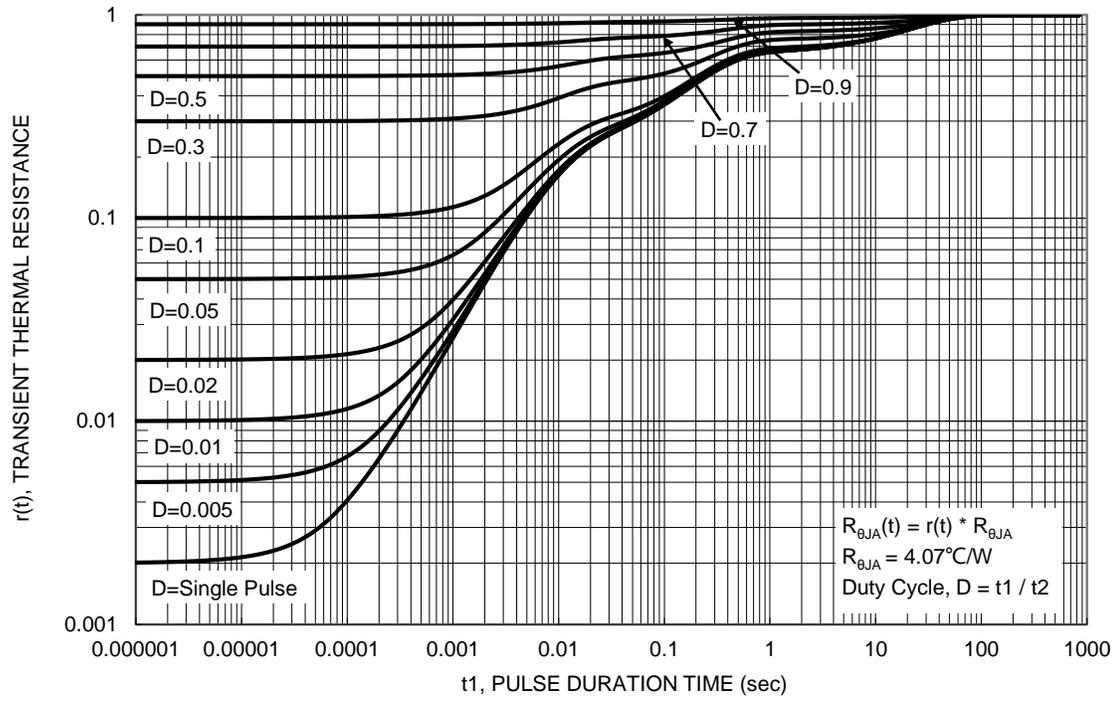
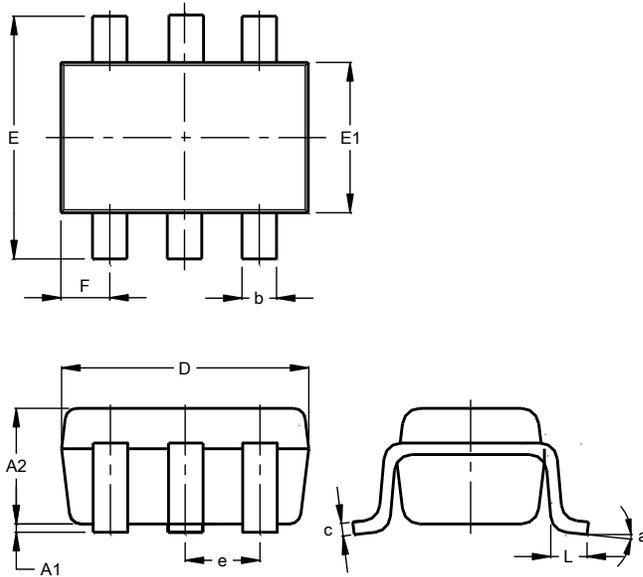


Figure 13. Transient Thermal Resistance

## Package Outline Dimensions

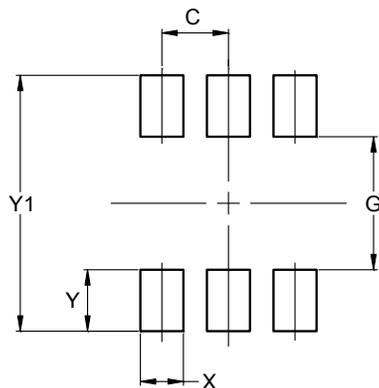
### SOT363



SOT363			
Dim	Min	Max	Typ
A1	0.00	0.10	0.05
A2	0.90	1.00	0.95
b	0.10	0.30	0.25
c	0.10	0.22	0.11
D	1.80	2.20	2.15
E	2.00	2.20	2.10
E1	1.15	1.35	1.30
e	0.650 BSC		
F	0.40	0.45	0.425
L	0.25	0.40	0.30
a	0°	8°	--
All Dimensions in mm			

## Suggested Pad Layout

### SOT363



Dimensions	Value (in mm)
C	0.650
G	1.300
X	0.420
Y	0.600
Y1	2.500